

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10578521	CHUN, JONG-YOON
Examiner	Art Unit	
SUCHIRA PANDE	1637	

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
Inventor name search in PALM	9/10/2008	SP
East Search	9/9/2008	SP
Google Search	9/20/2008	SP
West Search	July 2009	SP
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INTERFERENCE SEARCH

Class	Subclass	Date	Examiner